Features

- Fast read access time 120ns
- Dual voltage range operation
 - Unregulated battery power supply range, 2.7V to 3.6V, or
 - Standard power supply range, $5V\pm10\%$
- Compatible with JEDEC standard Atmel[®] AT27C040
- Low-power CMOS operation
 - 20µA max standby (less than 1µA, typical) for V_{CC} = 3.6V
 - 36mW max active at 5MHz for V_{CC} = 3.6V
- JEDEC standard packages
 - 32-lead PLCC
 - 32-lead TSOP
- High-reliability CMOS technology
 - 2,000V ESD protection
 - 200mA latchup immunity
- Rapid programming algorithm 100µs/byte (typical)
- CMOS- and TTL-compatible inputs and outputs
 - JEDEC standard for LVTTL and LVBO
- Integrated product identification code
- Industrial temperature range
- Green (Pb/halide-free, RoHS compliant) packaging

1. Description

The Atmel AT27BV040 chip is a high-performance, low-power, low-voltage, 4, 194, 304-bit, one-time programmable, read only memory (EPROM) organized as 512K by 8 bits. It requires only one supply in the range of 2.7 to 3.6V in normal read mode operation, making it ideal for fast, portable systems using either regulated or unregulated battery power.

The Atmel innovative design techniques provide fast speeds that rival 5V parts, while keeping the low power consumption of a 3V supply. At $V_{CC} = 2.7V$, any byte can be accessed in less than 100ns. With a typical power dissipation of only 18mW at 5MHz and $V_{CC} = 3V$, the AT27BV040 consumes less than one-fifth the power of a standard, 5V EPROM. Standby mode supply current is typically less than 1µA at 3V. The AT27BV040 simplifies system design and stretches battery lifetime even further by eliminating the need for power supply regulation.

The AT27BV040 is available in industry-standard, JEDEC-approved, one-time programmable (OTP) PLCC and plastic TSOP packages. All devices feature two-line control (\overline{CE} , \overline{OE}) to give designers the flexibility to prevent bus contention.

The AT27BV040 operating with V_{CC} at 3.0V produces TTL-level outputs that are compatible with standard TTL logic devices operating at V_{CC} = 5.0V. At V_{CC} = 2.7V, the part is compatible with JEDEC-approved, low-voltage battery operation (LVBO) interface specifications. The device is also capable of standard, 5V operation, making it ideally suited for dual supply range systems or card products that are pluggable in both 3V and 5V hosts.

The Atmel AT27BV040 has additional features to ensure high quality and efficient production use. The rapid programming algorithm reduces the time required to program the part and guarantees reliable programming. Programming time is typically only 100µs/byte. The





4Mb (512K x 8) Unregulated Battery Voltage, High-speed, One-time Programmable, Read Only Memory

Atmel AT27BV040

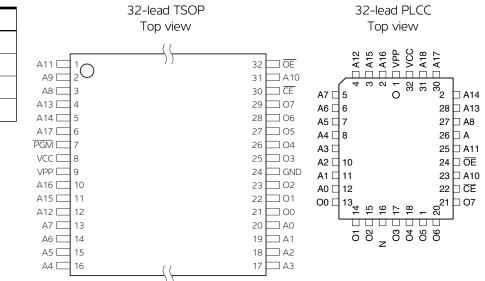
Not recommended for new designs



integrated product identification code electronically identifies the device and manufacturer. This feature is used by industrystandard programming equipment to select the proper programming algorithms and voltages. The AT27BV040 programs in exactly the same way as a standard, 5V Atmel AT27C040, and uses the same programming equipment.

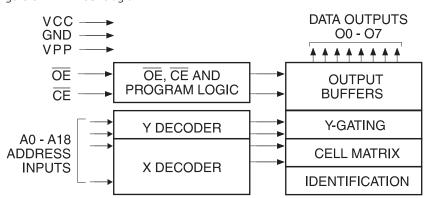
2. Pin configurations

Pin name	Function
A0 - A18	Addresses
00 - 07	Outputs
CE	Chip enable
ŌĒ	Output enable



3. Switching considerations

Switching between active and standby conditions via the chip enable pin may produce transient voltage excursions. Unless accommodated by the system design, these transients may exceed datasheet limits, resulting in device non-conformance. At a minimum, a 0.1μ F, high-frequency, low inherent inductance, ceramic capacitor should be utilized for each device. This capacitor should be connected between the V_{CC} and ground terminals of the device, as close to the device as possible. Additionally, to stabilize the supply voltage level on printed circuit boards with large EPROM arrays, a 4.7μ F bulk electrolytic capacitor should be utilized, again connected between the V_{CC} and ground terminals. This capacitor should be positioned as close as possible to the point where the power supply is connected to the array.





2 Atmel AT27BV040

4. Absolute maximum ratings*

Note: 1 Minimum voltage is -0.6V/DC which m	
V _{PP} supply voltage with respect to ground2.0V to +14.	0V ⁽¹⁾
Voltage on A9 with respect to ground2.0V to +14.	0V ⁽¹⁾
Voltage on any pin with respect to ground	0V ⁽¹⁾
Storage temperature65°C to +1	25°C
Temperature under bias40°C to +	-85°C

- *NOTICE: Stresses beyond those listed under "Absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
- Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20ns. Maximum output pin voltage is V_{CC} + 0.75V DC, which may be exceeded if certain precautions are observed (consult application notes), and which may overshoot to +7.0V for pulses of less than 20ns.

5. AC and DC charcteristics

Table 5-1.	Operating mode
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Mode/Pin	CE	ŌĒ	Ai	V _{PP}	V _{cc}	Outputs	
Read ⁽²⁾	VIL	V _{IL}	Ai	X ⁽¹⁾	V _{CC} ⁽²⁾	D _{OUT}	
Output disable ⁽²⁾	Х	V _{IH}	Х	Х	V _{CC} ⁽²⁾	High Z	
Standby ⁽²⁾	V _{IH}	Х	Х	Х	V _{CC} ⁽²⁾	High Z	
Rapid program ⁽³⁾	V _{IL}	V _{IH}	Ai	V _{PP}	V _{CC} ⁽³⁾	D _{IN}	
PGM verify ⁽³⁾	Х	V _{IL}	Ai	V _{PP}	V _{CC} ⁽³⁾	D _{OUT}	
PGM inhibit ⁽³⁾	V _{IH}	V _{IH}	Х	V _{PP}	V _{CC} ⁽³⁾	High Z	
Product identification ⁽³⁾⁽⁵⁾	V _{IL}	V _{IL}	$A9 = V_{H}^{(4)}$ $A0 = V_{H} \text{ or } V_{L}$ $A1 - A18 = V_{L}$	Х	V _{CC} ⁽³⁾	Identification code	

Notes: 1. X can be V_{IL} or V_{IH} .

- 2. Read, output disable, and standby modes require 2.7V \leq V_{CC} \leq 3.6V or 4.5V \leq V_{CC} \leq 5.5V.
- 3. Refer to programming characteristics. Programming modes require V_{CC} = 6.5V.
- 4. $V_{H} = 12.0 \pm 0.5 V.$
- 5. Two identifier bytes may be selected. All Ai inputs are held low (V_{IL}) except A9, which is set to $V_{H'}$ and A0, which is toggled low (V_{IL}) to select the manufacturer's identification byte and high (V_{IH}) to select the device code byte.

Table 5-2.	AC and DC operating conditions for read operation
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	Atmel AT27BV040-12
Industrial operating temperature (case)	-40°C − 85°C
V _{CC} power supply	2.7V to 3.6V
	5V ± 10%





Table 5-3. DC and operating characteristics for read operation

Symbol	Parameter	Condition	Min	Max	Units
$V_{CC} = 2.7 V$	to 3.6V				
ILI	Input load current	$V_{IN} = 0V$ to V_{CC}		±1	μA
I _{LO}	Output leakage current	$V_{OUT} = 0V$ to V_{CC}		±5	μA
I _{PP1} ⁽²⁾	V _{PP} ⁽¹⁾ read/standby current	V _{PP} = V _{CC}		10	μA
	I_{SB1} (CMOS), $\overline{CE} = V_{CC \pm} 0.3V$		20	μA	
I _{SB}	V _{CC} ⁽¹⁾ standby current	I_{SB2} (TTL), $\overline{CE} = 2.0$ to $V_{CC} + 0.5V$		100	μA
I _{CC}	V _{CC} active current	f = 5MHz, I_{OUT} = 0mA, $\overline{CE} = V_{IL}$, V_{CC} = 3.6V		10	mA
		V _{CC} = 3.0 to 3.6V	-0.6	0.8	V
V _{IL}	Input low voltage	V _{CC} = 2.7 to 3.6V	-0.6	0.2 x V _{CC}	V
.,		V _{CC} = 3.0 to 3.6V	2.0	V _{CC} + 0.5	V
V _{IH}	Input high voltage	V _{CC} = 2.7 to 3.6V	0.7 x V _{CC}	V _{CC} + 0.5	V
	I _{OL} = 2.0mA		0.4	V	
V _{OL}	V _{OL} Output low voltage	I _{OL} = 100μA		0.2	V
	I _{OL} = 20μA		0.1	V	
		I _{OH} = -2.0mA	2.4		V
V _{OH}	Output high voltage	Ι _{OH} = -100μΑ	V _{CC} - 0.2		V
		Ι _{OH} = -20μΑ	V _{CC} - 0.1		V
$V_{CC} = 4.5V$	to 5.5V		·		
I _{LI}	Input load current	$V_{IN} = 0V$ to V_{CC}		±1	μA
I _{LO}	Output leakage current	$V_{OUT} = 0V$ to V_{CC}		±5	μA
I _{PP1} ⁽²⁾	V _{PP} ⁽¹⁾ read/standby current	$V_{PP} = V_{CC}$		10	μA
	X (1)	I_{SB1} (CMOS), $\overline{CE} = V_{CC} \pm 0.3V$		100	μA
I _{SB}	V _{CC} ⁽¹⁾ standby current	I_{SB2} (TTL), \overline{CE} = 2.0 to V_{CC} + 0.5V		1	mA
I _{cc}	V _{CC} active current	f = 5MHz, I_{OUT} = 0mA, \overline{CE} = V_{IL}		30	mA
V _{IL}	Input low voltage		-0.6	0.8	V
V _{IH}	Input high voltage		2.0	V _{CC} + 0.5	V
V _{OL}	Output low voltage	I _{OL} = 2.1mA		0.4	V
V _{OH}	Output high voltage	I _{OH} = -400μA	2.4		V

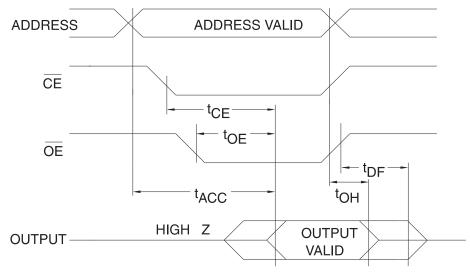
Notes: 1. V_{CC} must be applied simultaneously with or before V_{PP} , and removed simultaneously with or after V_{PP} .

2. V_{PP} may be connected directly to V_{CC} , except during programming. The supply current would then be the sum of I_{CC} and I_{PP} .

Table 5-4. AC characteristics for read operations V_{CC} = 2.7V to 3.6V and 4.5V to 5.5V

			Atmel AT2	7BV040-12	
Symbol	Parameter	Condition	Min	Max	Units
t _{ACC} ⁽³⁾	Address to output delay	$\overline{CE} = \overline{OE} = V_{IL}$		120	ns
t _{CE} ⁽²⁾	CE to output delay	$\overline{OE} = V_{IL}$		120	ns
t _{OE} ⁽²⁾⁽³⁾	OE to output delay	$\overline{CE} = V_{IL}$		50	ns
t _{DF} ⁽⁴⁾⁽⁵⁾	$\overline{\text{OE}}$ or $\overline{\text{CE}}$ high to output float, whichever occurred first			40	ns
t _{OH}	Output hold from address, CE or OE, whichever occurred first		0		ns

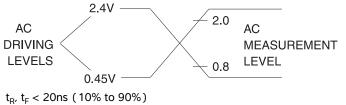
Figure 5-1. AC waveforms for read operation⁽¹⁾



Notes: 1. Timing measurement references are 0.8V and 2.0V. Input AC drive levels are 0.45V and 2.4V, unless otherwise specified.

- 2. $\overline{\text{OE}}$ may be delayed up to t_{CE} t_{OE} after the falling edge of $\overline{\text{CE}}$ without impact on t_{CE} .
- 3. $\overline{\text{OE}}$ may be delayed up to t_{ACC} t_{OE} after the address is valid without impact on t_{ACC}
- 4. This parameter is only sampled, and is not 100% tested.
- 5. Output float is defined as the point when data is no longer driven.









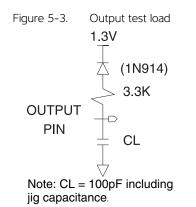


Table 5-5.Pin capacitance

 $f = 1MHz, T = 25°C^{(1)}$

Symbol	Тур	Max Units Condition		Conditions
C _{IN}	4	8	pF	$V_{IN} = OV$
C _{OUT}	8	12	pF	$V_{OUT} = 0V$

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled, and is not 100% tested.

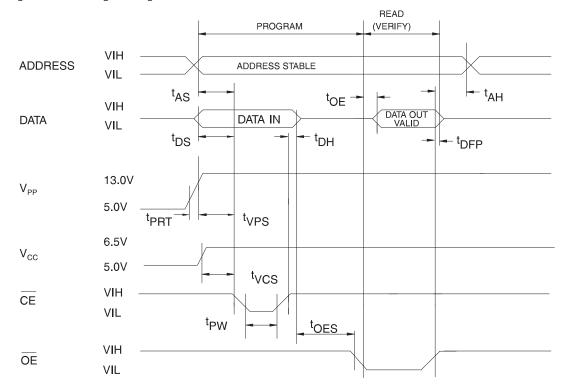


Figure 5-4. Programming waveforms⁽¹⁾

Notes: 1. The input timing reference is 0.8V for $V_{\rm IL}$ and 2.0V for $V_{\rm IH}$

- 2. t_{OE} and t_{DFP} are characteristics of the device, but must be accommodated by the programmer.
- 3. When programming the Atmel AT27BV040, a 0.1µF capacitor is required across V_{PP} and ground to suppress spurious voltage transients.

Table 5-6.DC programming characteristics

$T_A = 25 \pm 5^{\circ}C$, $V_{CC} = 6.5 \pm 0.25V$, $V_{PP} = 13.0 \pm 0.25V$

			Limits		
Symbol	Parameter	Test conditions	Min	Max	Units
I _{LI}	Input load current	$V_{\rm IN} = V_{\rm IL}, V_{\rm IH}$		±10	μA
V _{IL}	Input low level		-0.6	0.8	V
V _{IH}	Input high level		2.0	V _{CC} + 0.7	V
V _{OL}	Output low voltage	I _{OL} = 2.1mA		0.4	V
V _{OH}	Output high voltage	I _{OH} = -400μA	2.4		V
I _{CC2}	V_{CC} supply current (program and verify)			40	mA
I _{PP2}	V _{PP} supply current	$\overline{CE} = V_{IL}$		20	mA
V _{ID}	A9 product identification voltage		11.5	12.5	V

Table 5-7. AC programming characteristics

$T_A = 25 \pm 5^{\circ}$ C, $V_{CC} = 6.5 \pm 0.25$ V, $V_{PP} = 13.0 \pm 0.25$ V

			Lir	nits	
Symbol	Parameter	Test conditions ⁽¹⁾	Min	Max	Units
t _{AS}	Address setup time		2		μs
t _{OES}	OE setup time		2		μs
t _{DS}	Data setup time	 Input rise and fall times: (10% to 90%) 20 ns 	2		μs
t _{AH}	Address hold time		0		μs
t _{DH}	Data hold time	Input pulse levels:	2		μs
t _{DFP}	OE high to output float delay ⁽²⁾	0.45V to 2.4V	0	130	ns
t _{VPS}	V _{PP} setup time	Input timing reference level:	2		μs
t _{VCS}	V _{CC} setup time	0.8V to 2.0V	2		μs
t _{PW}	CE program pulse width ⁽³⁾	Output timing reference level:	95	105	μs
t _{OE}	Data valid from $\overline{OE}^{(2)}$	0.8V to 2.0V		150	ns
t _{PRT}	V _{PP} pulse rise time during programming		50		ns

Notes: 1. V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously with or after V_{PP} .

2. This parameter is only sampled and is not 100% tested. Output float is defined as the point where data is no longer driven. See timing diagram.

3. Program pulse width tolerance is $100\mu sec \pm 5\%$.

Table 5-8.	The Atmel AT27BV040 integrated product identification code ⁽¹⁾
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		Pins				Hex				
Codes	A0	07	O6	O5	04	O3	02	01	00	data
Manufacturer	0	0	0	0	1	1	1	1	0	1E
Device type	1	0	0	0	0	1	0	1	1	OB

Note: 1. The Atmel AT27BV040 has the same product identification code as the Atmel AT27C040. Both are programming compatible.



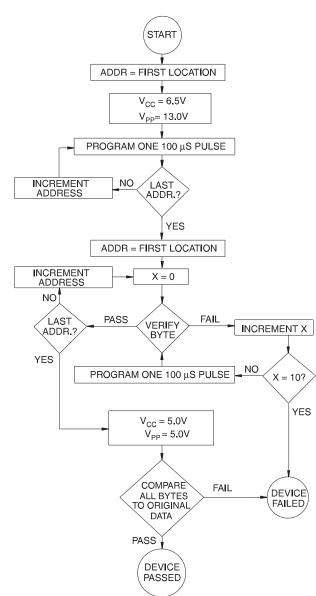
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6. Rapid programming algorithm

A 100 μ s \overline{CE} pulse width is used to program. The address is set to the first location. V_{CC} is raised to 6.5V and V_{PP} is raised to 13.0V. Each address is first programmed with one 100 μ s \overline{CE} pulse without verification. Then a verification/reprogramming loop is executed for each address. In the event a byte fails to pass verification, up to 10 successive 100 μ s pulses are applied with a verification after each pulse. If the byte fails to verify after 10 pulses have been applied, the part is considered failed. After the byte verifies properly, the next address is selected until all have been checked. V_{PP} is then lowered to 5.0V and V_{CC} to 5.0V. All bytes are read again and compared with the original data to determine if the device passes or fails.

Figure 6-1. Rapid programming algorithm



8

7. Ordering Information

Green package (Pb/halide-free, RoHS compliant)

t _{ACC}	I _{CC} (mA) V _{CC} = 3.6V					
(ns)	Active	Standby	Atmel ordering code	Package	Operation range	
120	120 0	0.02	AT27BV040-12JU	32J	Industrial	
120 0	0		AT27BV040-12TU	32T	(-40°C to 85°C)	

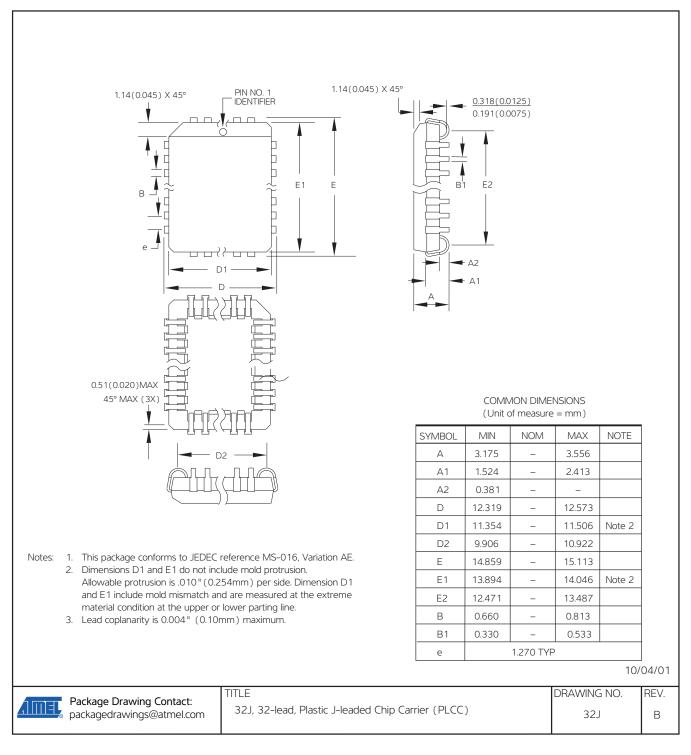
Package type				
32J	32-lead, plastic, J-Leaded chip carrier (PLCC)			
32T	32-lead, plastic, thin, small outline package (TSOP), 8 x 20mm			



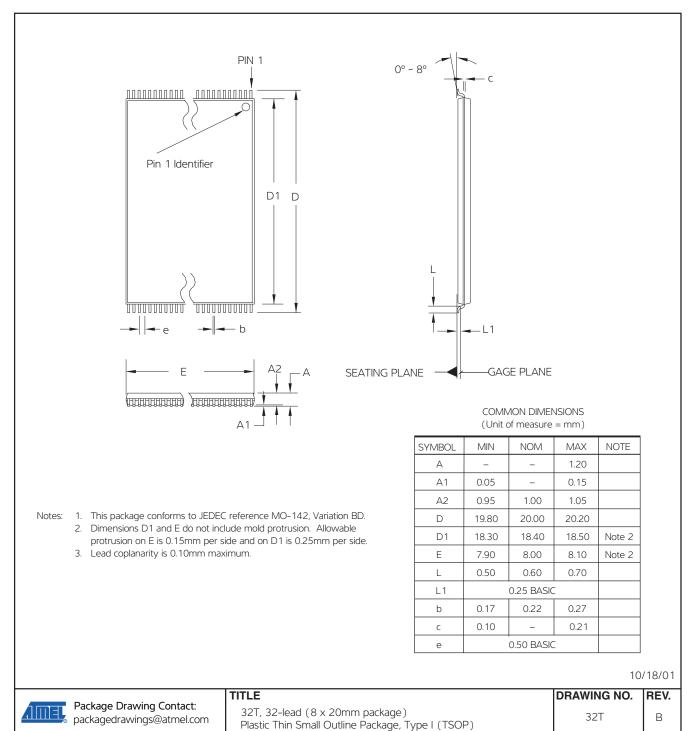


8. Packaging information

32J – PLCC



32T - TSOP





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9. Revision history

Doc. rev.	Date	Comments		
0346H	04/2011	Remove VSOP package Add "Not recommended for new designs"		
0346G	12/2007			



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